Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | CHEN, SANLIAN | Examiner | Art Unit | Gail Verbitsky | 2859 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,637,935	10-2003	Chen, Min-Ying	374/185
	В	US-6,854,880	02-2005	Hsieh, Chih-Wei	374/163
	С	US-2004/0264546	12-2004	Wong et al.	374/209
	D	US-		·	
	Ε	US-			
•••	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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	х							

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.